

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/557,108	MIZU ET AL.	
Examiner N. M. Minnifield		Art Unit 1645	Page 2 of 3	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0052763	03-2004	Mond et al.	424/093.2
*	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 98/18810-A1	05-1998	WO	Krieg et al	
*	O	WO 99/51259-A2	10-1999	WO	Krieg et al	
*	P	WO 99/56755-A1	11-1999	WO	Gramzinki et al	
	Q	WO 99/58118-A2	11-1999	WO	Wagner et al	
*	R	WO 97/40163-A1	10-1997	WO	Colpan et al	
*	S	WO 98/18810-A1	10-1997	WO 05/1998	Krieg et al	CE 6/410
*	T	WO 99/33488-A2	07-1999	WO	Dalemans et al	

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Matsumato et al, BBA, 2004, 1670:91-104
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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